



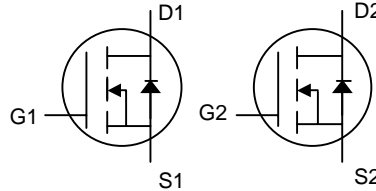
Dual N-channel Enhancement-mode Power MOSFET

Independent, Symmetrical Dual MOSFETs

Low Gate Charge

Low On-resistance

RoHS-compliant, halogen-free

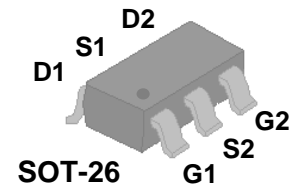


BV_{DSS}	30V
$R_{DS(ON)}$	72mΩ
I_D	3.3A

Description

Advanced Power MOSFETs from APEC provide the designer with the best combination of fast switching, low on-resistance and cost-effectiveness.

The SOT-26 package is widely used for commercial and industrial applications, where space is at a premium.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	30	V
V_{GS}	Gate-Source Voltage	±20	V
I_D at $T_A=25^{\circ}C$	Continuous Drain Current ³	3.3	A
I_D at $T_A=70^{\circ}C$	Continuous Drain Current ³	2.6	A
I_{DM}	Pulsed Drain Current ¹	10	A
P_D at $T_A=25^{\circ}C$	Total Power Dissipation	1.2	W
	Linear Derating Factor	0.01	W/°C
T_{STG}	Storage Temperature Range	-55 to 150	°C
T_J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Value	Unit
Rthj-a	Maximum Thermal Resistance, Junction-ambient	110	°C/W

Ordering Information

AP2626GY-HF-3TR : in RoHS-compliant, halogen-free SOT-26 shipped on tape and reel (3000pcs/reel)



Electrical Specifications at $T_j=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	30	-	-	V
$\Delta BV_{DSS}/\Delta T_j$	Breakdown Voltage Temperature Coefficient	Reference to $25^\circ\text{C}, I_D=1\text{mA}$	-	0.03	-	$V/^\circ\text{C}$
$R_{DS(ON)}$	Static Drain-Source On-Resistance ²	$V_{GS}=10V, I_D=3A$	-	-	72	$m\Omega$
		$V_{GS}=4.5V, I_D=2A$	-	-	120	$m\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	1	-	3	V
g_{fs}	Forward Transconductance	$V_{DS}=5V, I_D=3A$	-	2.8	-	S
I_{DSS}	Drain-Source Leakage Current ($T_j=25^\circ\text{C}$)	$V_{DS}=30V, V_{GS}=0V$	-	-	1	μA
	Drain-Source Leakage Current ($T_j=70^\circ\text{C}$)	$V_{DS}=24V, V_{GS}=0V$	-	-	25	μA
I_{GSS}	Gate-Source Leakage	$V_{GS}= \pm 20V$	-	-	± 100	nA
Q_g	Total Gate Charge ²	$I_D=3A$ $V_{DS}=25V$ $V_{GS}=4.5V$	-	3.2	5.1	nC
Q_{gs}	Gate-Source Charge		-	0.9	-	nC
Q_{gd}	Gate-Drain ("Miller") Charge		-	1.7	-	nC
$t_{d(on)}$	Turn-on Delay Time ²	$V_{DS}=15V$ $I_D=1A$ $R_G=3.3\Omega, V_{GS}=10V$	-	3.7	-	ns
t_r	Rise Time		-	10.1	-	ns
$t_{d(off)}$	Turn-off Delay Time		-	11.8	-	ns
t_f	Fall Time	$R_D=15\Omega$	-	2.3	-	ns
C_{iss}	Input Capacitance	$V_{GS}=0V$ $V_{DS}=25V$ $f=1.0\text{MHz}$	-	170	270	pF
C_{oss}	Output Capacitance		-	50	-	pF
C_{rss}	Reverse Transfer Capacitance		-	35	-	pF
R_g	Gate Resistance	$f=1.0\text{MHz}$	-	0.5	0.8	Ω

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_{SD}	Forward On Voltage ²	$I_S=1A, V_{GS}=0V$	-	-	1.2	V
t_{rr}	Reverse Recovery Time	$I_S=3A, V_{GS}=0V,$ $di/dt=100A/\mu s$	-	15	-	ns
Q_{rr}	Reverse Recovery Charge		-	8	-	nC

Notes:

1. Pulse width limited maximum junction temperature.
2. Pulse test pulse width < 300 μsec , duty cycle < 2%
3. Surface mounted on 1 in² copper pad of FR4 board, $t \leq 5\text{sec}$; 180 $^\circ\text{C}/\text{W}$ when mounted on minimum copper pad.

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

APEC DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

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Typical Electrical Characteristics

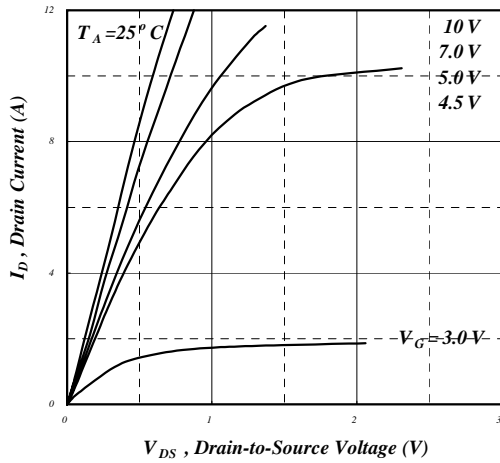


Fig 1. Typical Output Characteristics

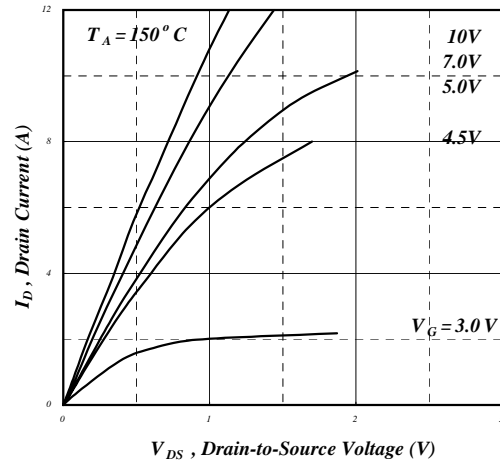


Fig 2. Typical Output Characteristics

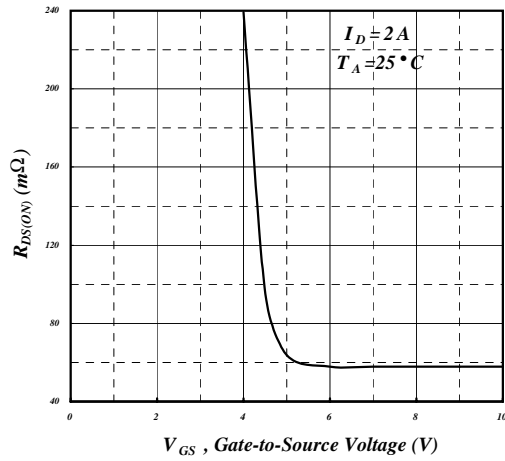


Fig 3. On-Resistance vs. Gate Voltage

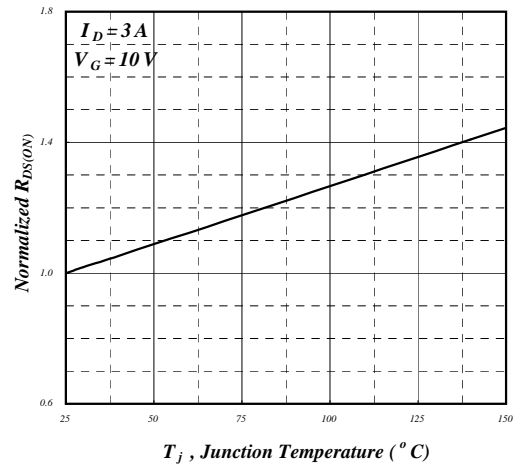


Fig 4. Normalized On-Resistance vs. Junction Temperature

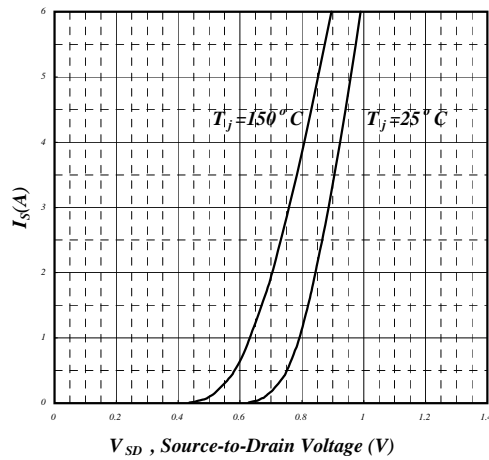


Fig 5. Forward Characteristic of Reverse Diode

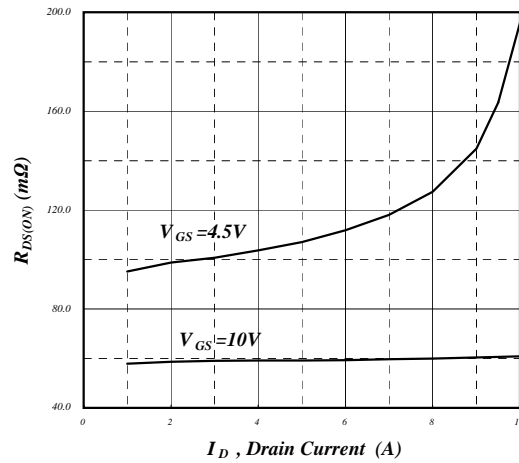


Fig 6. On-Resistance vs. Drain Current



Typical Electrical Characteristics (cont.)

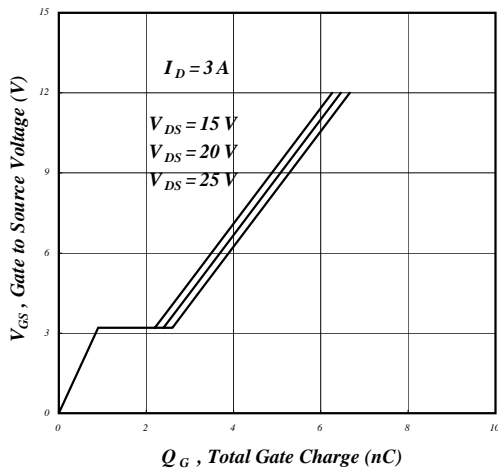


Fig 7. Gate Charge Characteristics

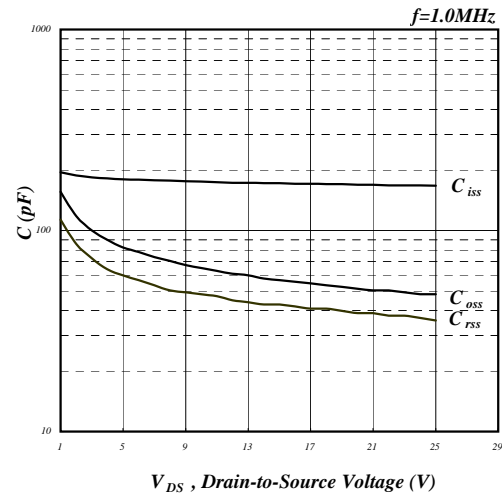


Fig 8. Typical Capacitance Characteristics

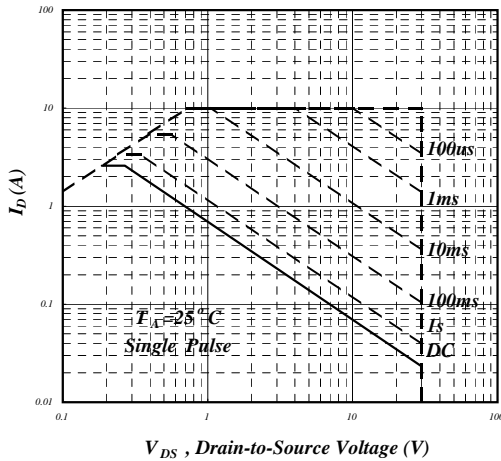


Fig 9. Maximum Safe Operating Area

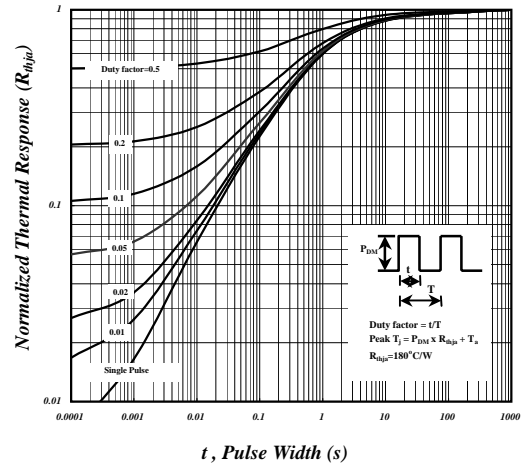


Fig 10. Effective Transient Thermal Impedance

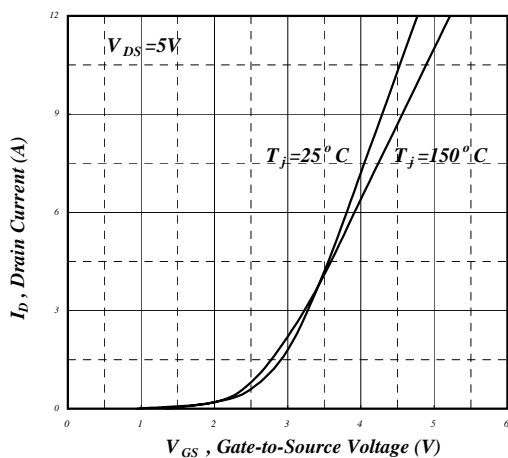


Fig 11. Transfer Characteristics

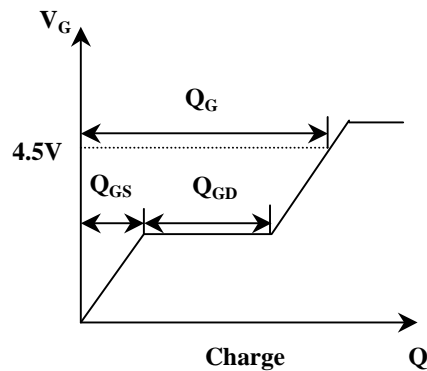
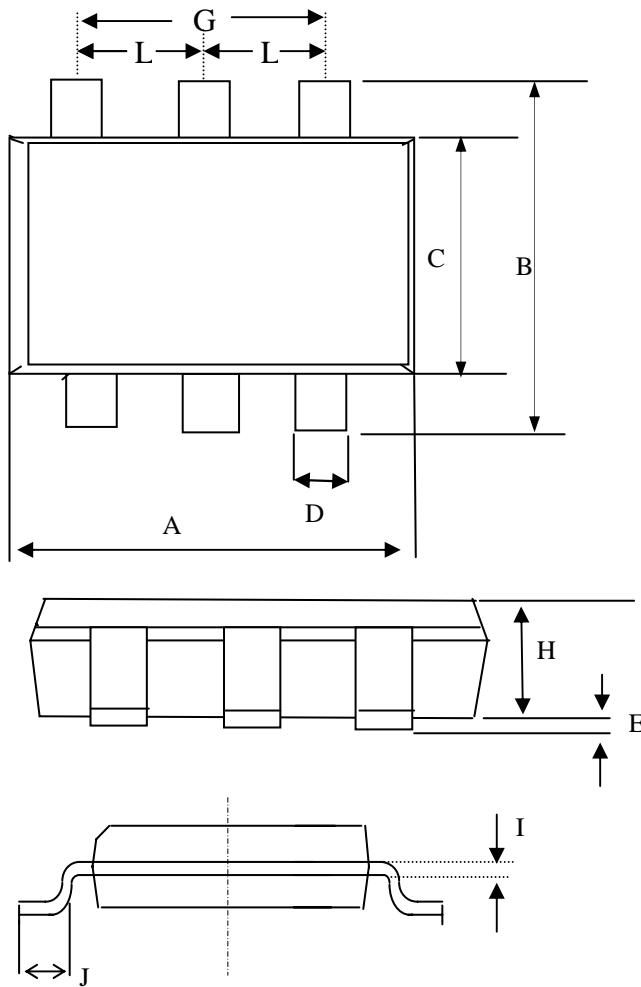


Fig 12. Gate Charge Waveform



Package Dimensions: SOT-26

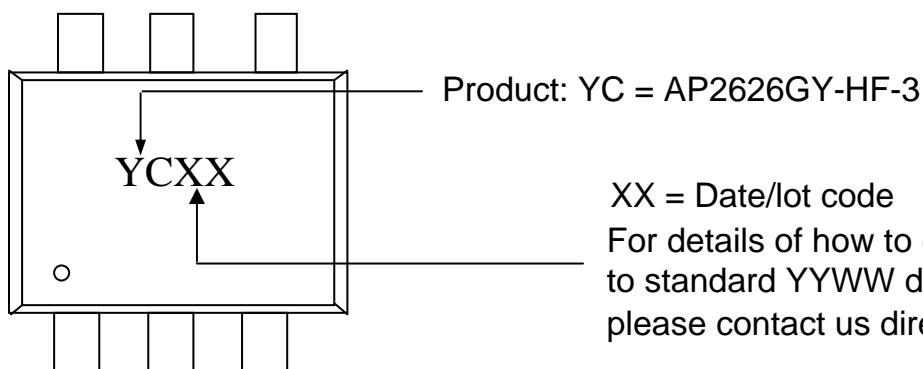


SYMBOLS	Millimeters		
	MIN	NOM	MAX
A	2.70	2.90	3.10
B	2.60	2.80	3.00
C	1.40	1.60	1.80
D	0.30	0.43	0.55
E	0.00	0.05	0.10
H	1.20REF		
G	1.90REF		
I	0.12REF		
J	0.37REF		
L	0.95REF		

1. All dimensions are in millimeters.
2. Dimensions do not include mold protrusions.

Marking Information:

Laser Marking



XX = Date/lot code
 For details of how to convert this to standard YYWW date code format, please contact us directly.